

Notice of References Cited	Application/Control No. 10/532,543		Applicant(s)/Patent Under Reexamination UENISHI ET AL.	
	Examiner M. Alexandra Elve		Art Unit 3742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,379,524	04-1968	KOPPIUS OTTO G	419/33
*	B	US-3,413,435	11-1968	SAM HOLTZCLAW JOHN	219/69.15
*	C	US-3,459,915	08-1969	KENNEY JAMES C; et. al.	75/240
*	D	US-3,670,137	06-1972	Inoue, Kiyoshi	219/76.13
*	E	US-3,745,296	07-1973	Shinopulos, George	219/69.15
*	F	US-4,373,127	02-1983	Haskett et al.	219/69.15
*	G	US-5,369,240	11-1994	Itoh, Tetsuro	219/69.15
*	H	US-2007/0172914	07-2007	Slabbekoorn et al.	435/068.1
*	I	US-4,027,134	05-1977	Arakawa et al.	219/69.15
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE3346912A1	12-1983	DE	Levit et al.	B23H 1/06
	O	JP4-322911	11-1992	JP	Takagi	B23H 1/06
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.